

L Number	Hits	Search Text	DB	Time stamp
1	227707	spacer	USPAT; US-PGPUB; JPO	2003/07/01 17:12
2	117384	silicon adj oxide) (silicon adj nitride	USPAT; US-PGPUB; JPO	2003/07/01 17:13
3	3113725	chromium cr aluminum al mo molybdenum	USPAT; US-PGPUB; JPO	2003/07/01 17:14
4	4427	spacer near5 (silicon adj oxide) (silicon adj nitride)	USPAT; US-PGPUB; JPO	2003/07/01 17:15
5	28946	349\$.ccls.	USPAT; US-PGPUB; JPO	2003/07/01 17:15
6	4184	spacer near5 (chromium cr aluminum al mo molybdenum)	USPAT; US-PGPUB; JPO	2003/07/01 17:15
8	69	349\$.ccls. and (spacer near5 (chromium cr aluminum al mo molybdenum))	USPAT; US-PGPUB; JPO	2003/07/01 17:15
7	33	(spacer near5 (silicon adj oxide) (silicon adj nitride)) and 349\$.ccls.	USPAT; US-PGPUB; JPO	2003/07/01 17:18

L Number	Hits	Search Text	DB	Time stamp
1	1	("5729312").PN.	USPAT; US-PGPUB	2003/07/01 14:42
2	450	349/141.CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:05
3	1368	(349/155,156).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:06
4	701754	projection	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:06
5	51585	(common counter) adj electrode	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:12
6	297	projection near10 ((common counter) adj electrode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:12
8	0	(projection near10 ((common counter) adj electrode)) and (349/141.CCLS. and ((349/155,156).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:12
9	312805	spacer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:12
11	0	349/141.CCLS. and ((projection near10 ((common counter) adj electrode)) same spacer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:12
10	15	(projection near10 ((common counter) adj electrode)) same spacer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:13
12	1	jp-08179330-\$.did.	JPO	2003/07/01 15:13
13	1	jp-11174466-\$.did.	JPO	2003/07/01 15:13
14	2	jp-08179330-\$.did. jp-11174466-\$.did.	JPO	2003/07/01 15:40
7	11	349/141.CCLS. and ((349/155,156).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:21
15	375961	dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:22
16	16880	spacer same dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:22
17	21	349/141.CCLS. and (spacer same dielectric)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:22
18	0	349/141.CCLS. AND spacer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:40

19	106	349/141.CCLS. and spacer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:52
20	2	("5995186" "6184957").PN.	USPAT	2003/07/01 15:47
21	53	349/141.CCLS. and projection	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/07/01 15:52